For Fundamental oscillation Low phase noise type KH9709ALx

Overview

KH9709ALx is composed of an oscillation amplifier, a frequency divider and a three-state output buffer. The amplifier is featured with damping resistor to reduce crystal drive current and suppress frequency deviation with VDD varying. ESD and latch-up test have complied with AEC-Q100 standard.

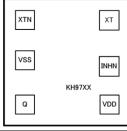
Features

Oscillation frequency (Fundamental)		4 to 60MHz		
Operating Voltage	fo≤60MHz	2.25 to 5.5V		
	fo≤80MHz	2.7 to 5.5V		
Operating T	-40 to 85°C			
Standby Mode INHN="L"		Q Output "Hi-z"		
		Oscillation Stopped		
INHN Input Voltage Level		C-MOS		
Q Output Duty Level		C-MOS		
Q Output Current		8mA (VDD=2.7V)		
Q Output Load (Drive Capacity)	2.25V\(\leq\VDD\(\leq 5.5V\)	30pF (≤60MHz)		
	2.7V≤VDD≤5.5V	50pF (≤60MHz)		
		30pF (≤80MHz)		

Device Selection Table

Version	Output
Version	frequency
KH9709AL1	fo
KH9709AL2	fo/2
KH9709AL3	fo/4
KH9709AL4	fo/8
KH9709AL5	fo/16
KH9709AL6	fo/32

PAD Locations

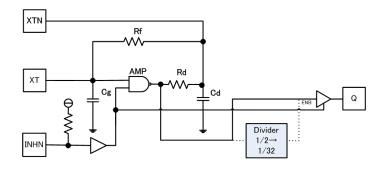


Chip Size	0.80×0.80mm	
PAD Size	90×90um	
Chip Thickness	200±20um	
Chip Base	VSS Level	

Reliability

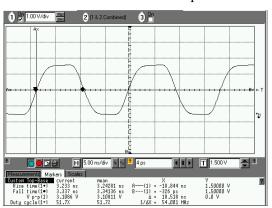
Test Model		Perfomance Values
ESD	HBM	>4000V
	MM	>400V
	FI-CDM	>1000V
Latch-up	Current Test	>200mA
	Voltage Test	>8.3V

Block Diagram



Output waveform

KH9709AL1 54MHz CL=32pF VDD=3.0V



Notes: The document is a brief data sheet of the products.

Please contact with us by email for detailed data sheet, when needed.

KAHO Rev.2